



• General Description

The ZM062N03M combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

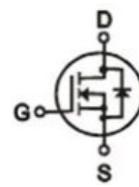
• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

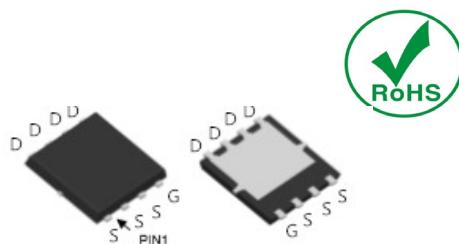
• Product Summary



$V_{DS}=30V$

$R_{DS(ON)}=6.5m\Omega$

$I_D=40A$



DFN3 x 3

• Ordering Information:

Part NO.	ZM062N03M
Marking	ZM062N03
Packing Information	REEL TAPE
Basic ordering unit (pcs)	5000

• Absolute Maximum Ratings ($T_c = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_D@T_c=25^\circ C$	40	A
	$I_D@T_c=75^\circ C$	30.4	A
	$I_D@T_c=100^\circ C$	25.2	A
	$I_D@T_A=25^\circ C$	12.9	A
	$I_D@T_A=70^\circ C$	10.4	A
Pulsed Drain Current ^①	I_{DM}	100	A
Total Power Dissipation ^②	$P_D@T_c=25^\circ C$	43	W
Total Power Dissipation	$P_D@T_A=25^\circ C$	2.3	W
Operating Junction Temperature	T_J	-55 to 150	°C
Storage Temperature	T_{STG}	-55 to 150	°C
Single Pulse Avalanche Energy	E_{AS}	210	mJ

**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case ^②	R _{thJC}	-	-	2.9	° C/W
Thermal resistance, junction - ambient	R _{thJA}	-	-	54	° C/W
Soldering temperature, wavesoldering for 10s	T _{sold}	-	-	265	° C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	30			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250uA	1.5	1.8	2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Static Drain-source On Resistance	R _{D(S)ON}	V _{GS} =10V, I _D =20A		6.5	8.5	mΩ
		V _{GS} =4.5V, I _D =10A		10	12	mΩ
Forward Transconductance	g _{FS}	V _{DS} =25V, I _D =10A		9		s
Source-drain voltage	V _{SD}	I _S =20A			1.28	V

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz	-	1150	-	pF
Output capacitance	C _{oss}		-	235	-	
Reverse transfer capacitance	C _{rss}		-	120	-	

•Gate Charge characteristics(T_a = 25°C)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Gate Resistance	R _g	f = 1MHz, V _{DS} =25V		1.8		Ω
Total gate charge	Q _g	V _{DD} =25V I _D = 5A V _{GS} = 10V	-	12	-	nC
Gate - Source charge	Q _{gs}		-	4	-	
Gate - Drain charge	Q _{gd}		-	6	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =10V, V _{DS} =15V		7.5		ns



Turn-ON Rise time	t_r	$R_G = 3.3\Omega$, $I_D = 15A$		12		ns
Turn-Off Delay time	$t_{D(off)}$			26		ns
Turn-Off Fall time	t_f			7.5		ns
Reverse Recovery Time	t_{RR}	VDD = 20 V, $dI/dt = 100A/\mu s$, $I_S = 15A$		9.7		ns
Charge Time	t_a			5.8		ns
Discharge Time	t_b			4.1		ns
Reverse Recovery Charge	Q_{RR}			2.9		nC

Note: ① Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$;

② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

Fig.1 Power Dissipation

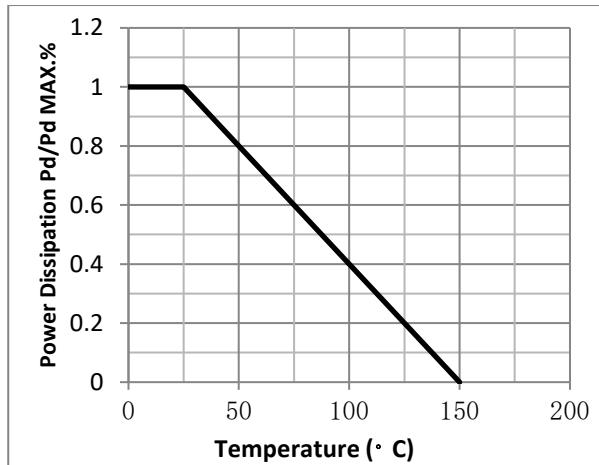


Fig.2 Typical output Characteristics

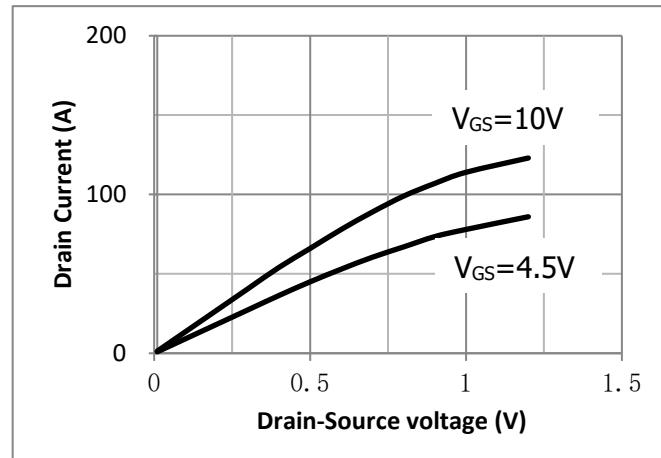


Fig.3 Threshold Voltage V.S Junction Temperature

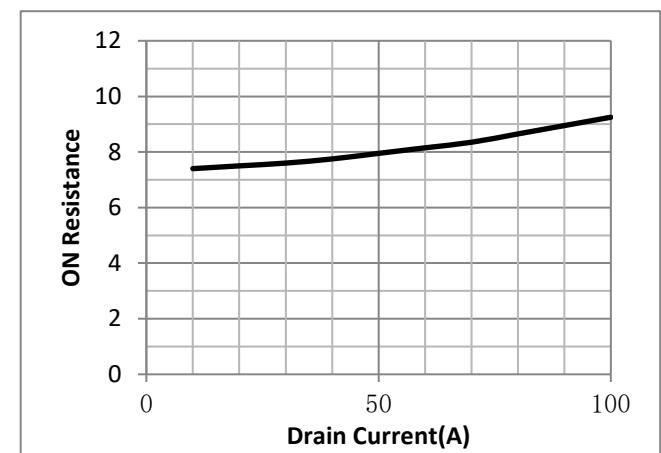
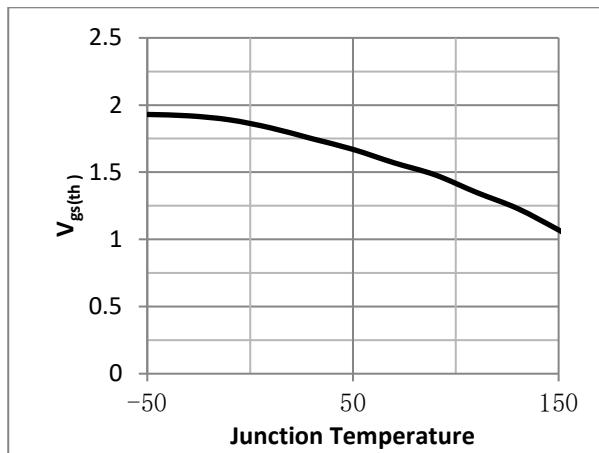


Fig.5 On-Resistance VS Gate Source Voltage

Fig.6 On-Resistance V.S Junction Temperature

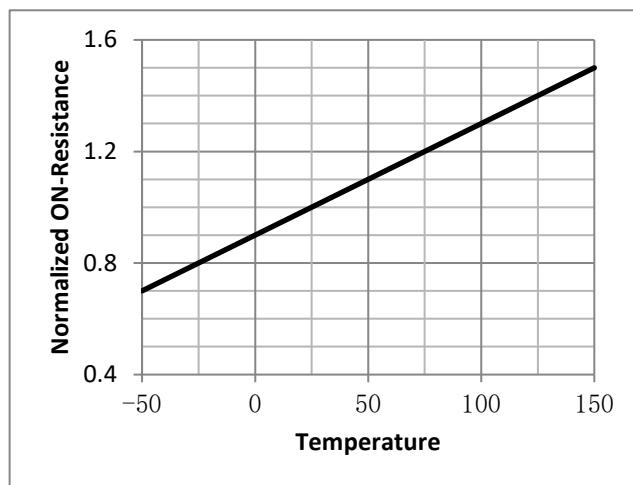
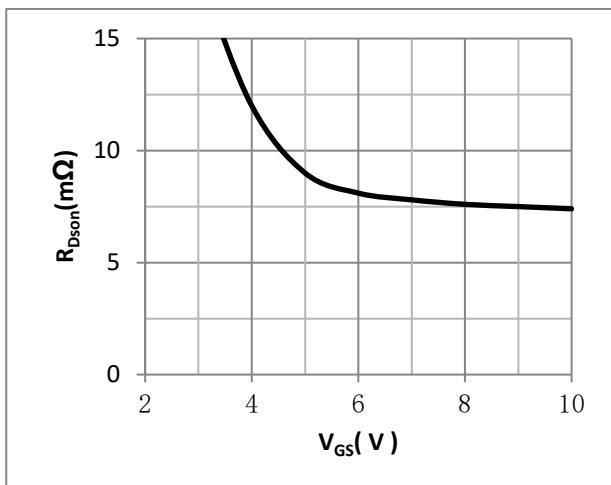


Fig.7 SOA Maximum Safe Operating Area

Figure 8. Diode Forward Voltage vs. Current

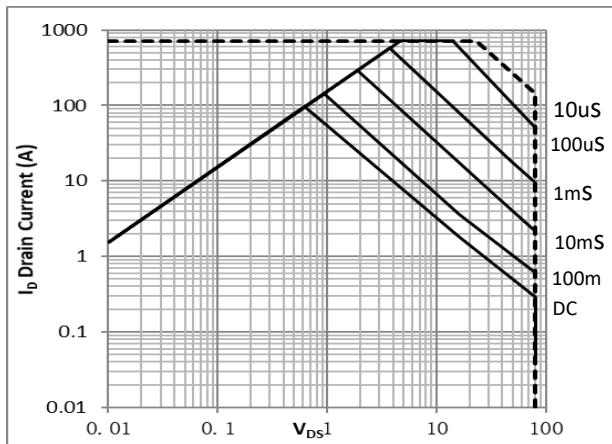


Figure 9. Transfer Characteristics

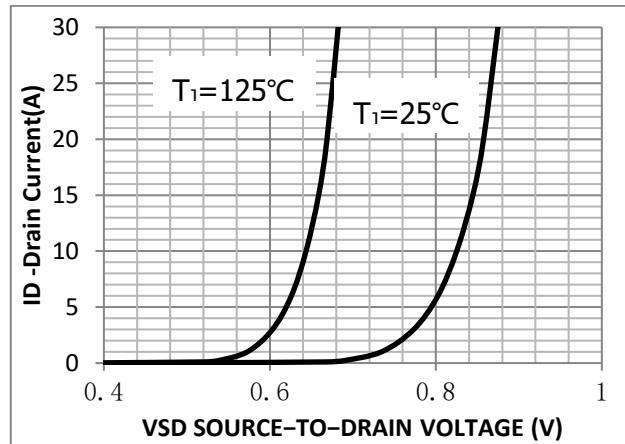


Fig.10 Typical output Characteristics

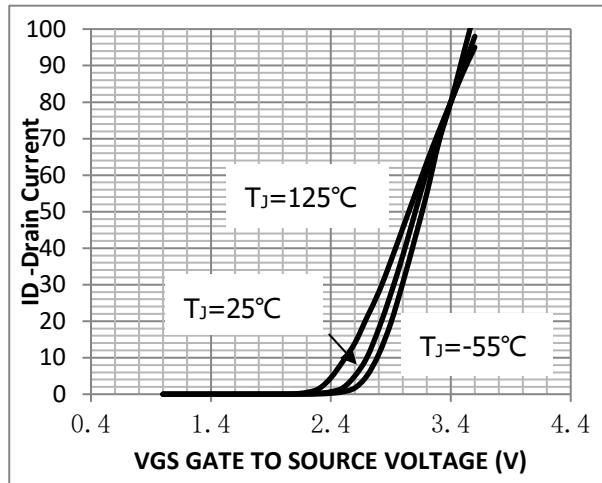
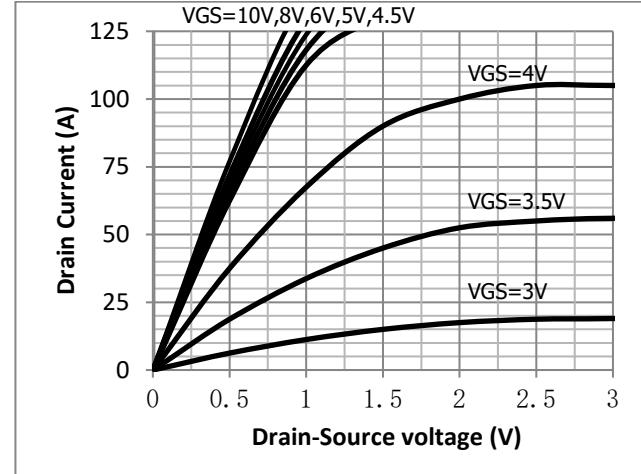
Fig.11 I_D V.S Junction Temperature

Fig.12 Switching Time Measurement Circuit

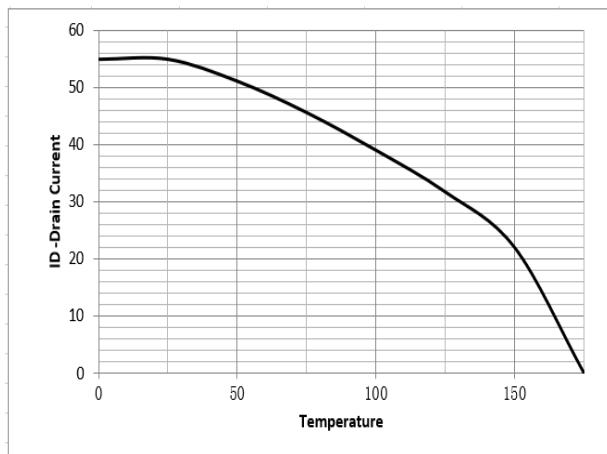


Fig.13 Gate Charge Waveform

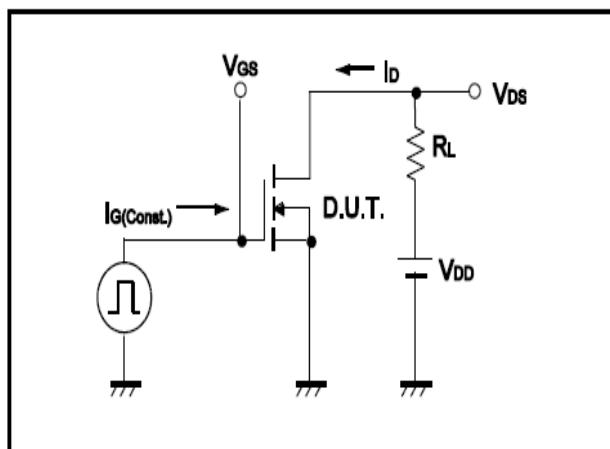


Fig.14 Avalanche Waveform

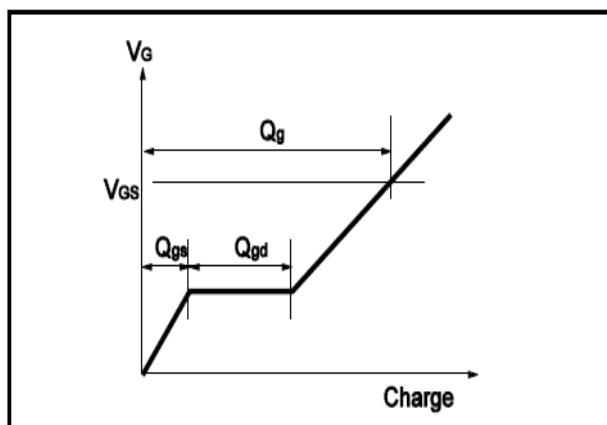


Fig.15 Resistive Switching Test Circuit

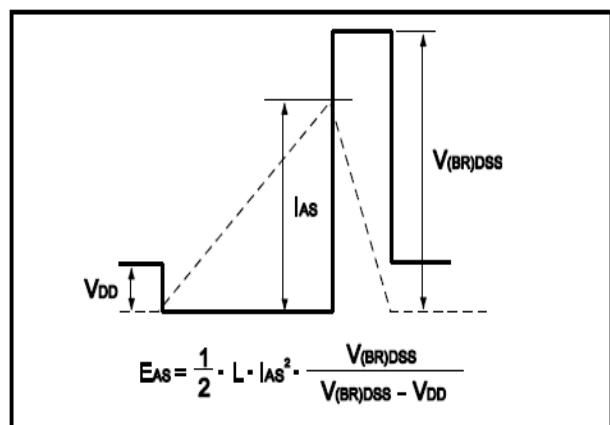


Fig.16 Resistive Switching Test Waveform

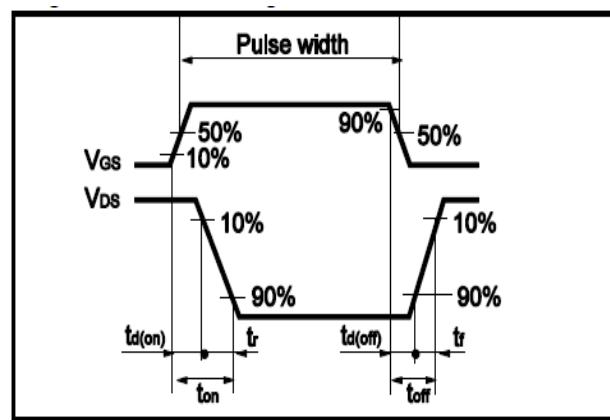
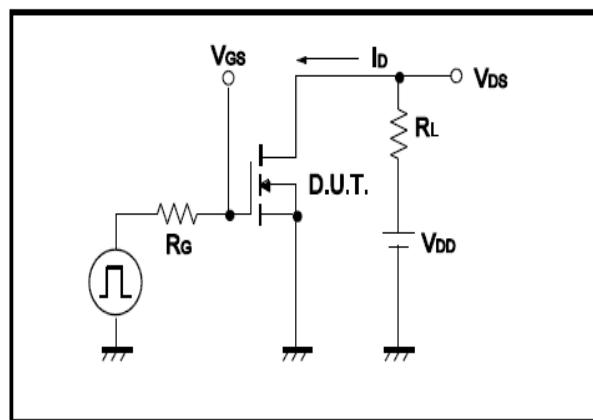
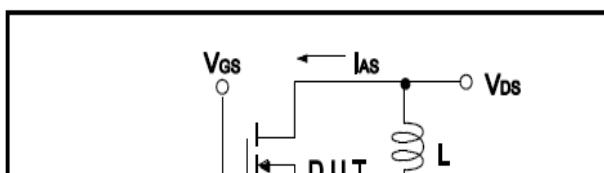


Fig.17 Avalanche Measurement Circuit





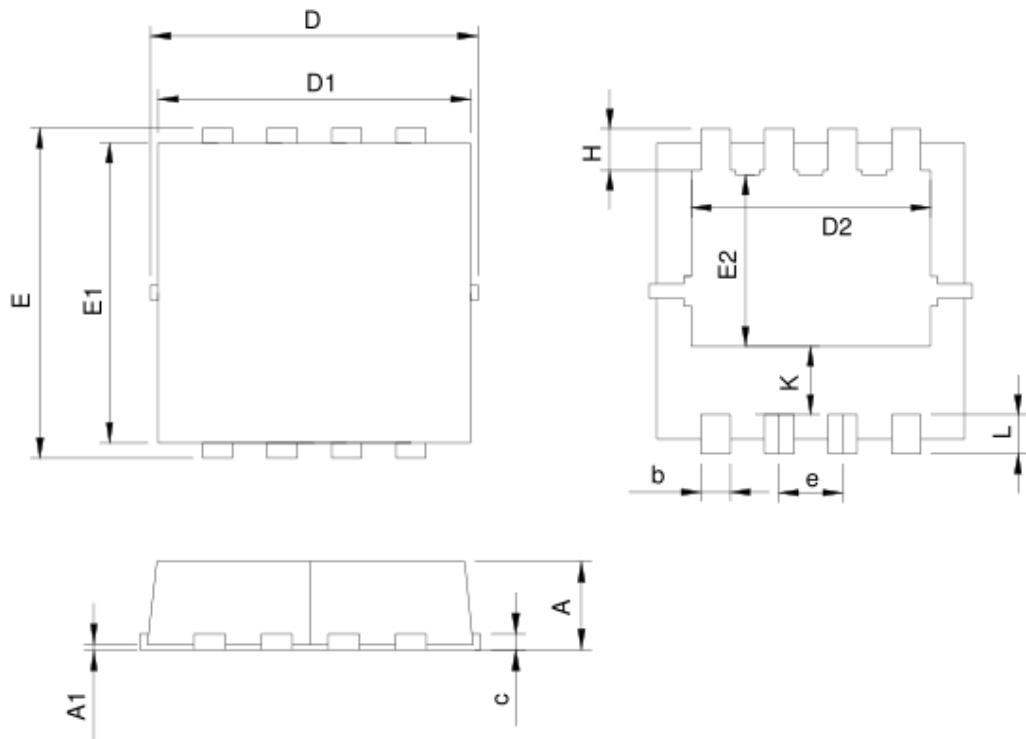
ZMJ SEMICONDUCTOR CO., LTD

ZM062N03M
30V N-Channel Power MOSFET

•Dimensions(DFN3×3)

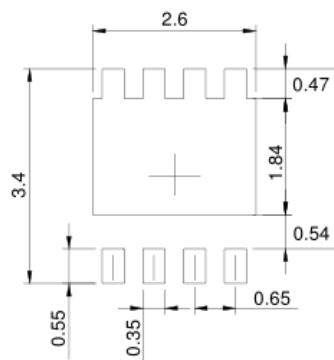


Unit: mm



SYMBOL	DFN3.3x3.3-8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	1.00	0.028	0.039
A1	0.00	0.05	0.000	0.002
b	0.25	0.35	0.010	0.014
c	0.14	0.20	0.006	0.008
D	3.10	3.50	0.122	0.138
D1	3.05	3.25	0.120	0.128
D2	2.35	2.55	0.093	0.100
E	3.10	3.50	0.122	0.138
E1	2.90	3.10	0.114	0.122
E2	1.64	1.84	0.065	0.072
e	0.65 BSC		0.026 BSC	
H	0.32	0.52	0.013	0.020
K	0.59	0.79	0.023	0.031
L	0.25	0.55	0.010	0.022

RECOMMENDED LAND PATTERN



UNIT: mm